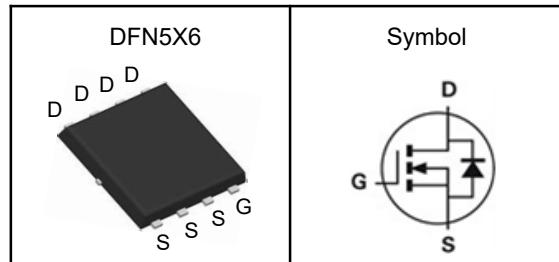


N-Channel Enhancement Mode MOSFET

Features

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant
- 100% UIS and Rg Tested

Pin Description



Applications

- Power Management in Desktop Computer
- DC/DC Converters

V_{DSS}	40	V
$R_{DS(ON)-Typ}$	4	$\text{m}\Omega$
I_D	75	A

Absolute Maximum Ratings ($T_c=25^\circ\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit
V_{DSS}	Drain-Source Voltage	40	V
V_{GSS}	Gate-Source Voltage	± 20	V
T_J	Maximum Junction Temperature	-55 to 150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
EAS	Single Pulse Avalanche Energy ^③	98	mJ
$I_{DM}^{①}$	Pulse Drain Current Tested	144	A
I_D	Continuous Drain Current	$T_c=25^\circ\text{C}$	A
P_D	Maximum Power Dissipation	$T_c=25^\circ\text{C}$	W

Thermal Characteristics

Symbol	Parameter	Rating	Unit
R_{JA}	Thermal Resistance-Junction to Ambient	62	$^\circ\text{C}/\text{W}$
R_{JC}	Thermal Resistance Junction-Case ^④	3.5	$^\circ\text{C}/\text{W}$

Note ① : Max. current is limited by bonding wire.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C .

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz.

N-Channel Enhancement Mode MOSFET

Electrical Characteristics ($T_J=25^\circ\text{C}$, Unless Otherwise Noted)

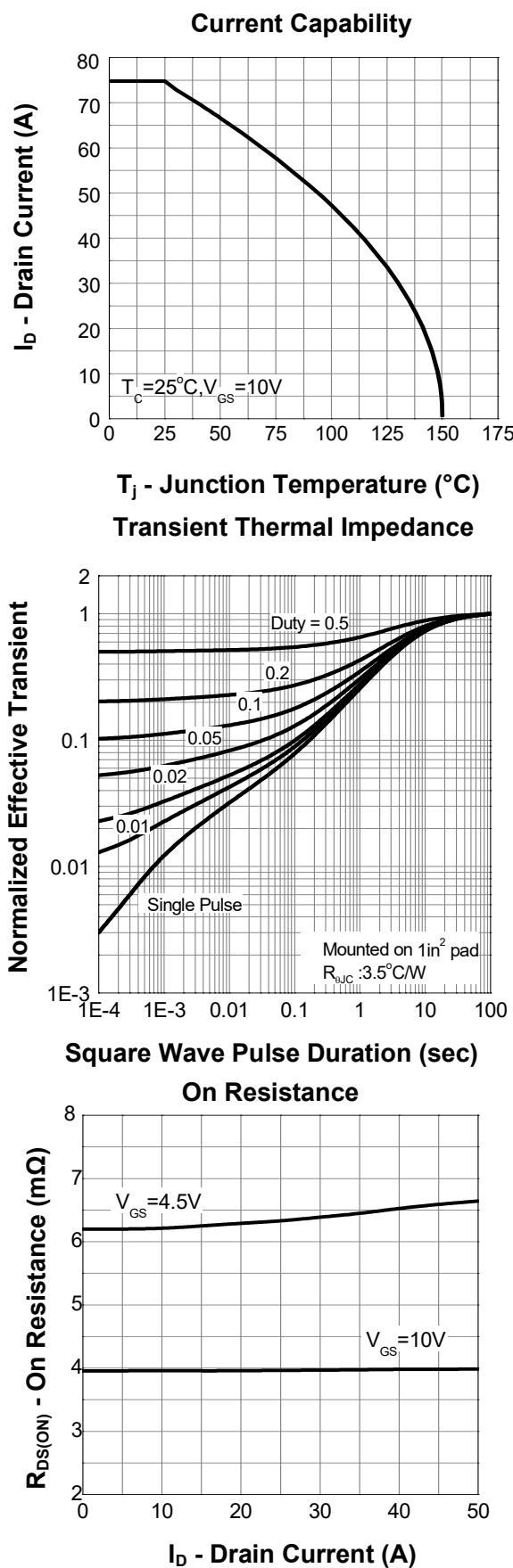
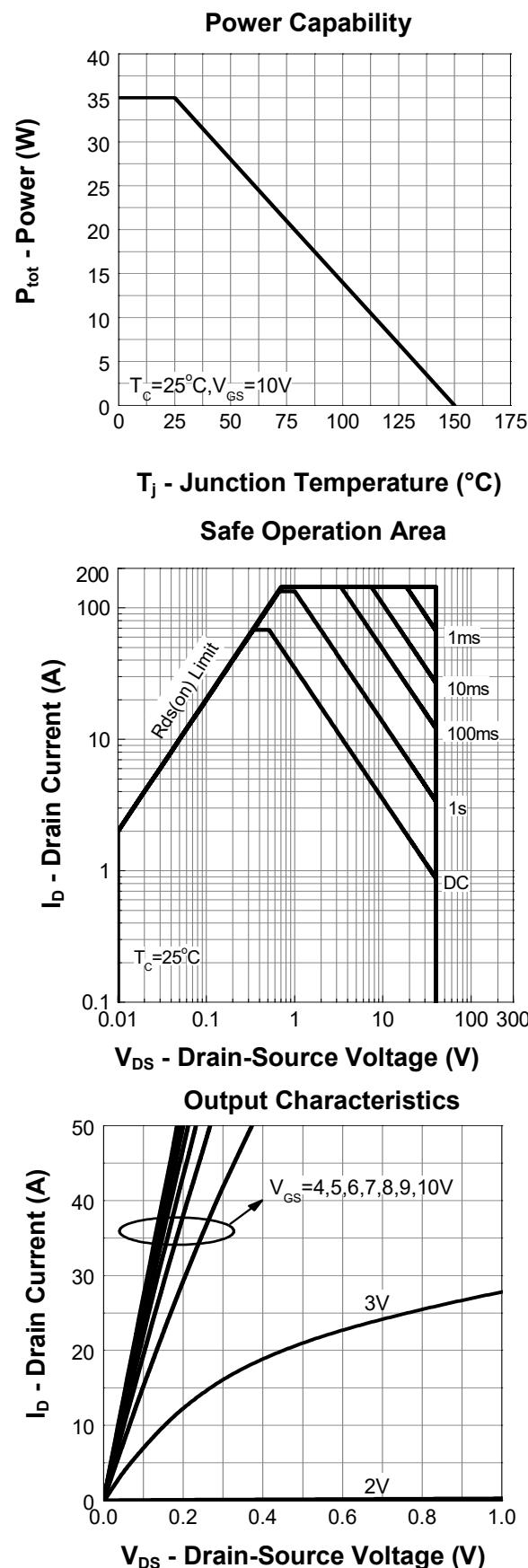
Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_{\text{D}}=250\mu\text{A}$	40	---	---	V
$I_{\text{DS}}^{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=32\text{V}$, $V_{\text{GS}}=0\text{V}$	---	---	1	μA
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=250\mu\text{A}$	1.0	---	2.0	V
I_{GSS}	Gate Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
$R_{\text{DS}(\text{ON})}$	Drain-Source On-state Resistance	$V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=15\text{A}$	---	4	4.8	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_{\text{D}}=8\text{A}$	---	6.2	7.5	$\text{m}\Omega$
Dynamic Characteristics^⑤						
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=20\text{V}$, Freq.=1MHz	---	938	---	pF
C_{oss}	Output Capacitance		---	366	---	
C_{rss}	Reverse Transfer Capacitance		---	60	---	
$T_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=20\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_{\text{G}}=3.9\Omega$, $I_{\text{D}}=15\text{A}$	---	6	---	nS
T_r	Turn-on Rise Time		---	26	---	
$T_{\text{d(off)}}$	Turn-off Delay Time		---	27	---	
T_f	Turn-off Fall Time		---	24	---	
Q_g	Total Gate Charge	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=15\text{A}$	---	24	---	nC
Q_{gs}	Gate-Source Charge		---	3.8	---	
Q_{gd}	Gate-Drain Charge		---	6	---	
Source-Drain Characteristics						
$V_{\text{SD}}^{④}$	Diode Forward Voltage	$I_{\text{S}}=15\text{A}$, $V_{\text{GS}}=0\text{V}$	---	---	1.3	V

Note ④ : Pulse test (pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$).

Note ⑤ : Guaranteed by design, not subject to production testing.

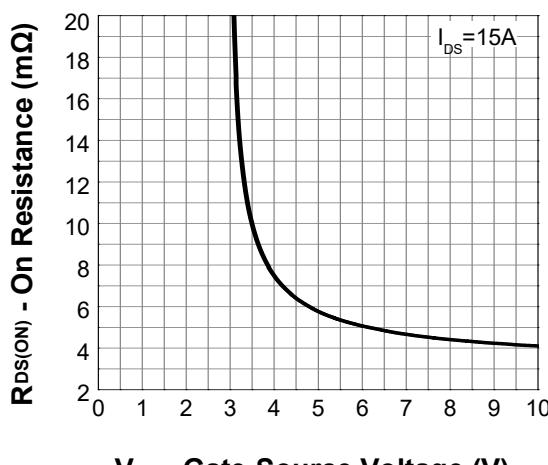
N-Channel Enhancement Mode MOSFET

Typical Characteristics



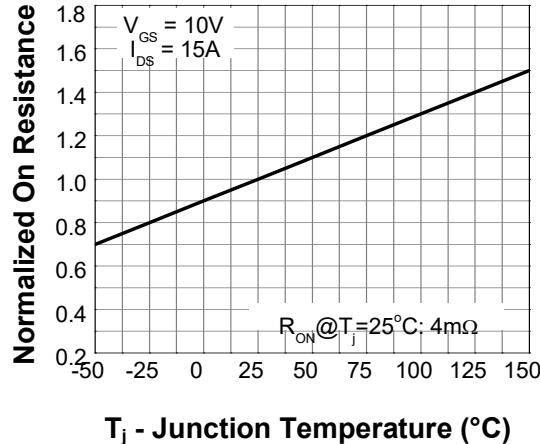
N-Channel Enhancement Mode MOSFET

Transfer Characteristics



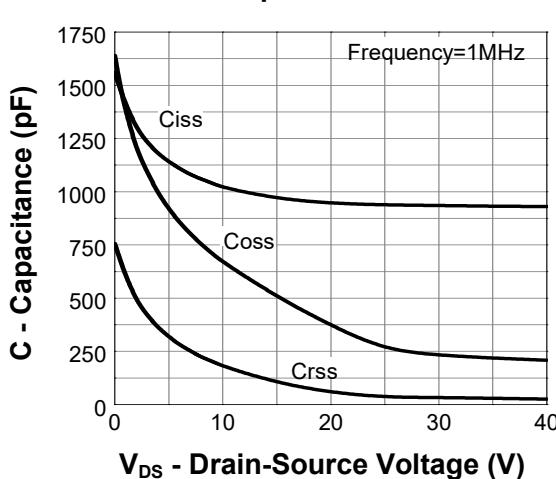
$I_{DS} = 15\text{A}$

Normalized On Resistance



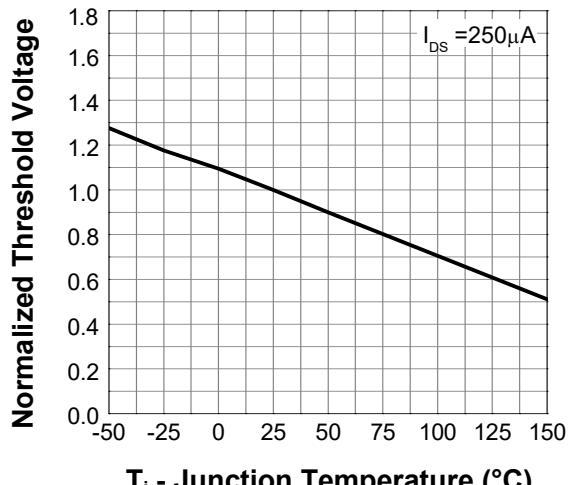
$V_{GS} = 10\text{V}$
 $I_{DS} = 15\text{A}$

Capacitance



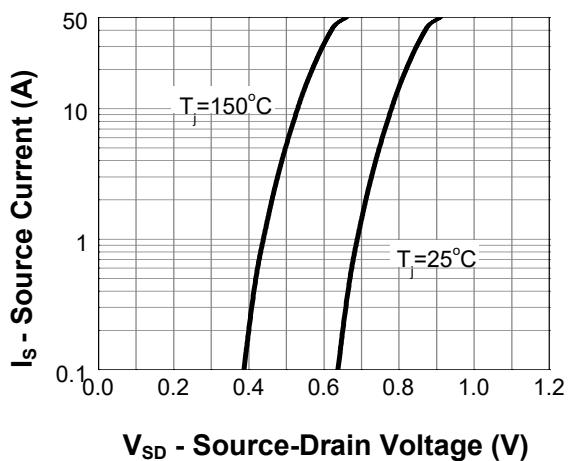
Frequency=1MHz

Normalized Threshold Voltage



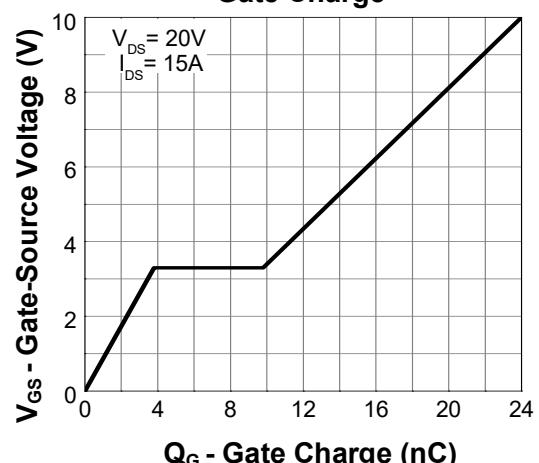
$I_{DS} = 250\mu\text{A}$

Diode Forward Current



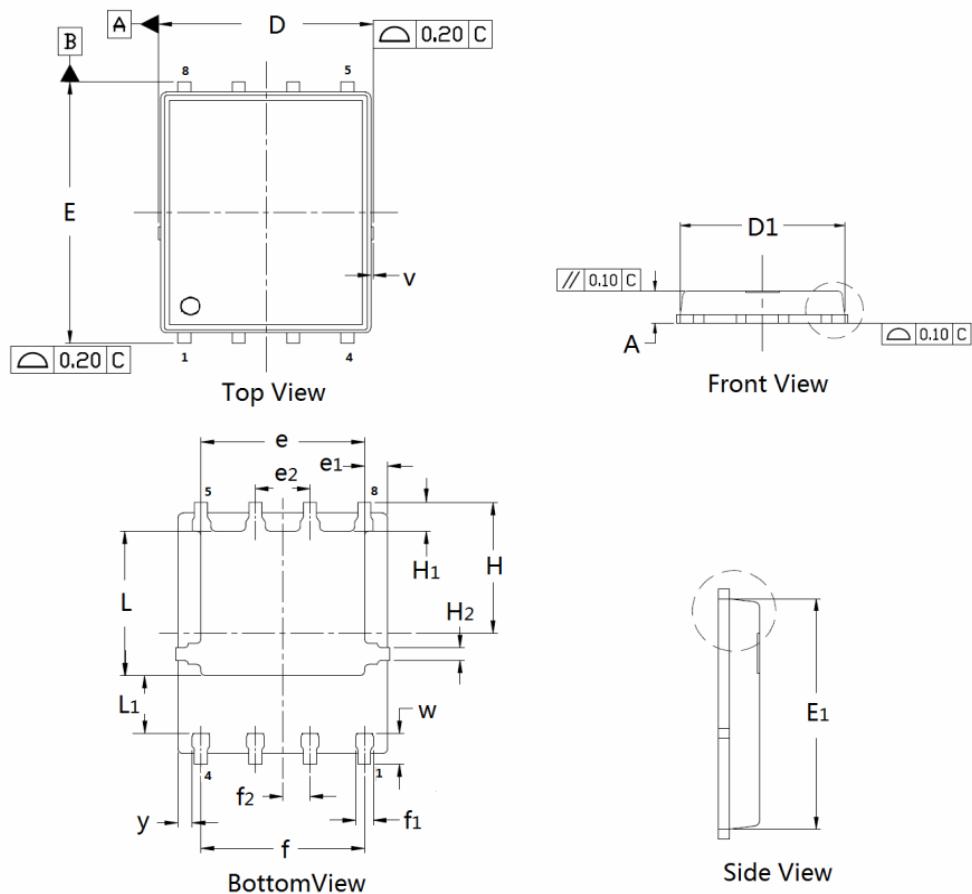
$T_j = 150^{\circ}\text{C}$
 $T_j = 25^{\circ}\text{C}$

Gate Charge



N-Channel Enhancement Mode MOSFET

DFN5×6 Package Outline Data



DIMENSIONS (unit : mm)

Symbol		Typ	Max	Symbol	Min	Typ	Max
A	0.90	1.02	1.10	D	4.90	4.98	5.10
D₁	4.80	4.89	5.10	E	5.90	6.11	6.25
E₁	5.65	5.74	5.95	e	3.72	3.80	3.92
e₁	--	0.5	--	e₂	--	1.	--
f	--	3.8	--	f₁	0.31	0.37	0.51
f₂	--	0.6	--	H	--	3.	--
H₁	0.59	0.63	0.79	H₂	0.26	0.28	0.32
L	3.35	3.45	3.65	L₁	--	1.	--
V	--	0.1	--	w	0.64	0.68	0.84
y	--	0.3	--		--		--